Partition and combinatorial testing

Angelo Gargantini – Corso Testing e verifica del software

Outline

- What is combinatorial testing
 - Efficiency: It can detect faults
- Partition testing
 - A method to apply partition testing
 - How to choose variable values
- Combinatorial interaction of parameters
- Generation techniques
 - IPO, AETG, IPOS
- Adding constraints
 - Logic approach, using SAT/SMT solving

What is Combinatorial testing

- It can be classified "input space" testing or testing based on the interfaces
- No internal information about the system under test is considered, but only the information about the inputs
- It can be model based testing
 - Model of the inputs
- Program based testing
 - The program is analyzed to extract the parameters
 - E.g. the parameters of a method. ...

Advantages of Input based testing

- Can be equally applied at several levels of testing
 - Unit
 - Integration
 - System
- Relatively easy to apply
 - Test generation is simple, simpler than structure based testing or fault based
- Easy to adjust the procedure to get more or fewer tests
- No implementation knowledge is needed
 - just the input space
 - Usable even if the complete code/model is not accessible

Combinatorial testing is effective

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CIT effectiveness

Experiments show that CIT is

effective

finds faults that traditional testing may be not able to find

efficient

- A low degree of interaction between inputs can already discover most faults
 - Pairwise is the most used
- Never with interaction > 6

Effectiveness -1

- Compared to a traditional company that would use the quasi-exhaustive strategy, the Combinatorial design method (CDM) strategy would reduce its system level test schedule by sixty-eight percent (68%) and save sixtyseven percent (67%) in labor costs associated with the testing.
- Reference: Raytheon (2000). Jerry Huller. Reducing Time to Market with Combinatorial Design Method Testing.

Effectiveness -2 - Kuhn @ NIST

- Maximum interactions for fault triggering was
 6
- Reasonable evidence that maximum interaction strength for fault triggering is relatively small



Effectiveness - 3

- More experiments are needed
- New experiments are welcome!

```
Combinatorial testing is better than structural testing ?
```

Combinatorial testing is better than random testing ?

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Partition testing

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Problems ...

- The <u>input domain</u> to a program contains all the possible inputs to that program
 - For even small programs, the input domain is so large that it might as well be <u>infinite</u>
- Testing is fundamentally about <u>choosing finite</u> <u>sets</u> of values from the input domain

Solution: Input partitioning

- Domain for each input parameter is <u>partitioned into regions</u>
 - The domain is substituted by an enumeration

Partitioning Domains

- <u>Domain</u> D
- Partition scheme q of D
- The partition q defines a <u>set of blocks</u>, $Bq = b_{1,b2}$

, ... bQ

The partition must satisfy two properties :

blocks must be *pairwise disjoint* (no overlap)



Using Partitions – Assumptions

- Choose a value from each partition
- Each value is assumed to be equally useful for testing
- Application to testing
 - Find <u>characteristics</u> in the inputs : parameters, semantic descriptions, ...
 - Partition each characteristics
 - <u>Choose tests</u> by combining values from characteristics
- Example <u>Characteristics</u>
 - Input X is null -> true or false
 - Order of the input file F -> sorted, inverse sorted, arbitrary
 - Min separation of two aircraft -> integer 0 ... 1000
 - Input device -> DVD, CD, VCR, computer

Choosing Partitions

- Choosing (or defining) partitions seems easy, but is easy to get wrong
- Consider a file the contains word in some "order"



Properties of Partitions

- If the partitions are not complete or disjoint, that means the partitions have not been considered carefully enough
- They should be reviewed carefully, like any <u>design</u> attempt
- Different alternatives should be considered

Example for program based testing

Java

```
enum Color { RED, GREEN, BLU}
```

Void foo(long x, Color c, boolean value)

Color and boolean domain already partitioned. What about long domain?

Example of partition, from **Boundary Value Analysis**

MAX_VALUE

A constant holding the maximum value a long can have, 263-1.

MIN_VALUE

A constant holding the minimum value a long can have, -263.

BETWEEN MAX E MIN?

Partition for long

Partitions in 5 subsets



Partition of cartesian product

- Given two domains D1 and D2
- Let P1 a partition for D1 and P2 a partition for D2
- Partitions can be multiplied to obtain again partitions
- D1 x D2 can be partitioned by P1 X P2
- P1 x P2 will contain all the combinations of P1 and P2

Product of partitions, application

- For more than one input:
- /** given three sides return the type
 of the triangle*/
 TriType Triang(int Side1,int Side2,int Side3)
- If one splits every input in 5 subsets, the input is partitioned in 5 x 5 x 5 = 125 subsets

Partition testing

- Several methods are based on partition testing [see books by Myers, and Beizer]:
- 1. Equivalent Partition
- 2. Domain Testing
- 3. Boundary Value Analysis
- 4. Category Partition [Ostrand Balcer 1988]:
 - Identify the parameters and variables and their choices
 - Generate all combinations (test frames)

Partition does not solve the problem!

- Category partition testing gave us
 - Systematic approach: Identify characteristics and values (the creative step),
 - generate combinations (the mechanical step)
- While equivalence partitioning offers a set of guidelines to design test cases, it suffers from two shortcomings:
- 1. It raises the possibility of a large number of subdomains in the partition.
 - Test suite size grows very rapidly with number of categories. Can we use a non-exhaustive approach?
- 2. It lacks guidelines on how to select inputs from various sub-domains in the partition.

Angelo Gargantini -Testing e verifica del From Partition testing to combinatorial testing

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A. Input Domain Modeling

Step 1 : Identify testable functions

- Individual methods have one testable function
- In a class, each method has the same characteristics
- Programs have more complicated characteristics—modeling documents such as UML use cases can be used to design characteristics
- Systems of integrated hardware and software components can use devices, operating systems, hardware platforms, browsers, etc

• Step 2 : Find all the parameters

- Often fairly straightforward, even mechanical
- Important to be complete
- Methods : Parameters and state (non-local) variables used
- Components : Parameters to methods and state variables
- System : All inputs, including files and databases

Modeling the Input Domain (cont)

Step 3 : Model the input domain

- The domain is scoped by the parameters
- The structure is defined in terms of characteristics
- Each characteristic is partitioned into sets of blocks
- Each block represents a set of values
- This is the most creative design step in applying ISP

STEP 3: Modeling the Input Domain

- Partitioning characteristics into blocks and values is a very creative engineering step
- More blocks means more tests
- The partitioning often flows directly from the definition of characteristics and both steps are sometimes done together
 - Should evaluate them separately sometimes fewer characteristics can be used with more blocks and vice versa
- Strategies for identifying values :
 - Include valid, invalid and special values
 - Sub-partition some blocks
 - Explore boundaries of domains
 - Include values that represent "normal use"
 - Try to balance the number of blocks in each characteristic
 - Check for completeness and disjointness

Two Approaches to Input Domain Modeling (IDM)

1. Interface-based approach

- Develops characteristics directly from individual input parameters
- Simplest application
- Can be partially automated in some situations
- 2. Functionality-based approach
 - Develops characteristics fro a behavioral view of the program under test
 - Harder to develop—requires more design effort
 - May result in better tests, or fewer tests that are as effective

1. Interface-Based Approach

- Mechanically consider each parameter in isolation
- This is an easy modeling technique and relies mostly on syntax
- Some domain and semantic information won't be used
 - Could lead to an incomplete IDM
- Ignores relationships among parameters

Consider TriTyp

Three int parameters

IDM for each parameter is identical

Reasonable characteristic : Relation of side with zero

2. Functionality-Based Approach

- Identify characteristics that correspond to the intended functionality
- Requires more design effort from tester
- Can incorporate domain and semantic knowledge
- Can use relationships among parameters
- Modeling can be based on requirements, not implementation
- The same parameter may appear in multiple characteristics, so it's harder to translate values to test cases

Consider TriTyp again

The three parameters

IDM can combine all parameters

Reasonable characteristic : Type of triangle

Interface-Based IDM – TriTyp

<u>TriTyp</u>, had one testable function and three integer inputs

First Characterization of TriTyp's Inputs				
Characteristic	b ₁	b ₂	b ₃	
q ₁ = "Relation of Side 1 to 0"	greater than 0	equal to 0	less than 0	
q ₂ = "Relation of Side 2 to 0"	greater than 0	equal to 0	less than 0	
q ₃ = "Relation of Side 3 to 0"	greater than 0	equal to 0	less than 0	

- A maximum of 3*3*3 = 27 tests
- Some triangles are valid, some are invalid
- Refining the characterization can lead to more tests ...



- A maximum of 4*4*4 = 64 tests
- This is only complete because the inputs are inte

Possible values for partition q1



Functionality-Based IDM – TriTyp

- First two characterizations are based on <u>syntax</u>-parameters and their type
- A <u>semantic</u> level characterization could use the fact that the three <u>Geometric</u> Characterization of TriTyp's Inputs

Characteristic	b ₁	b ₂	b ₃	b ₄
q ₁ = "Geometric Classification"	scalene	isosceles	equilateral	invalid

- Oops ... something's fishy ... equilateral is also isosceles !
- We need to refine the example to make characteristics valid



Combination Strategies criteria

- Step 4 : Apply a test criterion to choose combinations of values
 - A test input has a value for each parameter
 - One block for each characteristic
 - Choosing all combinations is usually infeasible
 - Coverage criteria allow subsets to be chosen
- Step 5 : Refine combinations of blocks into test inputs
 - Choose appropriate values from each block

Choosing Combinations of Values

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Step 4 – Choosing Combinations of Values

- Once characteristics and partitions are defined, the next step is to <u>choose test values</u>
- We use <u>criteria</u> to choose <u>effective</u> subsets
- The most obvious criterion is to choose all combinations ...

<u>All Combinations (ACoC)</u> : All combinations of blocks from all characteristics must be used.

- Number of tests is the product of the number of blocks in each characteristic : $\prod_{i=i}^{a} B_{i}$
- The second characterization of TriTyp results in 4*4*4
 <u>64 tests</u> too many ?

Example of "Too many" !



34 switches = 2³⁴ = 1.7 x 1010 possible inputs = 1.7 x 1010 test standards and Technology ????

Too much – some assumptions

- What if we knew that **one** single switch always causes the fault?
 2 tests would be enough to find if the system is correct:
 - all off, all on
 - What if we knew no failure involves more than **3 switch** settings interacting?

If only 3-way interactions, need only 33 tests For 4-way interactions, need only 85 tests



ISP Criteria – Each Choice

- 64 tests for TriTyp is almost certainly way too many
- One criterion comes from the idea that we should try at least one value from each block

Each Choice (EC) : One value from each block for each characteristic must be used in at least one test case.

- Number of tests is the number of blocks in the largest characteristic $Max \stackrel{Q}{_{i=1}}(B_{i})$

For TriTyp

- Three inputs side1,side2, side3
- Four values each 2,1,0,-1
- A test with 4 test is enough:
 - 2, 2, 2 1, 1, 1 0, 0, 0 -1, -1, -1

ISP Criteria – Pair-Wise

- Each choice yields few tests cheap but perhaps ineffective
- Another approach asks values to be combined with other values

<u>Pair-Wise (PW)</u> : A value from each block for each characteristic must be combined with a value from every block for each other characteristic.

• Number of tests is at least the product of two largest characteristics $(Max \ _{i=1}^{Q}(B_{i})) * (Max \ _{j=1, j!=i}^{Q}(B_{j}))$

For TriTyp:

- 2, 2, 2 2, 1, 1 2, 0, 0 2, -1, -1
- 1, 2, 11, 1, 01, 0, -11, -1, 20, 2, 00, 1, -10, 0, 20, -1, 1

-1, 2, -1 -1, 1, 2 -1, 0, 1 -1, -1, 0

Combinatorial approach

- Pairwise combination instead of exhaustive
 - Generate combinations that efficiently cover all pairs of values
 - Rationale: most failures are triggered by single values or combinations of a few values. Covering pairs (triples,...) reduces the number of test cases, but reveals most faults
 - Extended by t-wise: test all the combinations of t values

Example

Display Mode	Color	Screen size
full-graphics	Monochrome	Hand-held
Low resolution	16-bit	Laptop
text-only	True-color	Full-size

- ► **3 variables with 3 values each: 3**^{3 = 27 possible combinations}
- **Combinatorial testing with much fewer tests**

Test Suite - example

pairwise testing can be achieved by only 9 tests

Test	Color	Display Mode	Screen Size	
1	Monochrome	Full-graphics	Hand-held	
2	16-bit	Text-only	Laptop	
3	True-color	Full-graphics	Hand-held	
4				

One test covers many combinations: e.g. Test 1 covers 3 pairs: (Monochrome, Fullgraphics) (Monochrome, Handheld) (Full-graphics, Handheld)

Other figures:

2^{100} combinations with 10 tests; 1020 \Box 200

tests; ...

ISP Criteria –T-Wise

A natural extension is to require combinations of *t* values instead of **2**

<u>t-Wise (TW)</u> : A value from each block for each group of t characteristics must be combined.

- Number of tests is at least the product of t largest characteristics
- If all characteristics are the same size, the formula is $(Max {}^Q_{i=1}(B_i))^t$
- If t is the number of characteristics Q, then all combinations
- That is $\dots Q$ -wise = AC
- *t*-wise is expensive and benefits are not clear Angelo Gargantini - Testing e verifica del SW UNIBG AA 13-14

ISP Coverage Criteria Subsumption



Exercise

• example system: component based application

CLIENT	WEB SERVER	PAYMENT	DATABASE
FIREFOX	WEB SPHERE	MASTER CARD	DB/2
IE	APACHE	VISA	ORACLE
OPERA	.NET	AMEX	ACCESS

One test is missing ...

► 3⁴exhaustives

test cases es

> 9 test cases

CLIENT	WEB SERVER	PAYMENT	DATABASE
FIREFOX	WEB SPHERE	MASTER CARD	DB/2
FIREFOX	.NET	AMEX	ORACLE
FIREFOX	APACHE	VISA	ACCESS
IE	WEB SPHERE	AMEX	ACCESS
IE	APACHE	MASTER CARD	ORACLE
IE	.NET	VISA	DB/2
OPERA	WEB SPHERE	VISA	ORACLE
OPERA	.NET	MASTER CARD	ACCESS

Generation techniques

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Generation techniques families

- Algebraic
 - Based on some mathematical/algebraic properties
- Search based, greedy, based on heuristics
 - Because the problem of generating a minimum test suit for combinatorial testing is NP-complete, most methods and tools use a greedy approach
- Logic based
 - Based on SAT/SMT solving and model checking

Classification

- Algebraic methods that are mainly developed by mathematicians
 - Latin squares, Orthogonal arrays, Covering arrays
 - Recursive Construction
- Search-Based methods that are mainly developed by computer scientists
 - AETG (from Telcordia), TCG (from JPL/NASA), DDA (from ASU), PairTest/Fireeye (from NIST)
 - Incremental construction

Search-Based vs Algebraic Methods

- Algebraic methods:
 - Advantages: very fast, and often produces optimal results
 - Disadvantages: limited applicability, difficult to support parameter relations and constraints
 - E.g. most work only if all the parameters have the same domain size
- Search-based methods:
 - Advantages: no restrictions on the input model, and very flexible, e.g., relatively easier to support parameter relations and constraints
 - Disadvantages: explicit search takes time, the resulting test sets are not optimal

Greedy methods

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Greedy methods

- Parameter based
 - One colum at the time
 - ► **IPO**
 - IPOS still room to improve
- Test case based

- Add one test at the time
 - ► AETG

IPO: In-Parameter-Order

- Originally presented in:
- Yu Lei, K. C. Tai, "In-Parameter-Order: A Test Generation Strategy for Pairwise Testing," High-Assurance Systems Engineering, IEEE International Symposium on, p. 254, Third IEEE International High-Assurance Systems Engineering Symposium, 1998
- Several extensions
- ► NIST

http://csrc.nist.gov/groups/SNS/acts/

TOOL: FireEye, now ACTS

IPO: In-Parameter-Order

- Builds a t-way test set in an incremental manner
 - 1. A t-way test set is first constructed for the first t parameters, simply considering their combinations
 - 2. Then, the test set is extended to generate a t-way test set for the first t + 1 parameters
 - 3. The test set is repeatedly extended for each additional parameter.
- **Two steps involved in each extension for a new parameter:**
 - Horizontal growth: extends each existing test by adding one value of the new parameter
 - Vertical growth: adds new tests, if necessary

Adding parameters



Strategy In-Parameter-Order

/* step 1: for the first t parameters **p**_{1, p2, ..., pt*/}

```
T := {(v1, v2, ..., vt) | v1, v2, ..., vt are values of p1, p2, ..., pt }
```

if n = t then stop;

```
/* step 2: for the remaining parameters */
```

```
for parameter pi, i = t + 1, ..., n do
```

```
begin /* add parameter pi */
```

```
/* 2a: horizontal growth */
```

```
for each test (v1, v2, ..., vi-1) in T do
```

replace it with (v1, v2, ..., vi-1, vi), where vi is a value of pi

```
/* 2b: vertical growth */
```

```
while T does not cover all the interactions between pi and
```

```
each of p1, p2, ..., pi-1 do
```

add a new test for p1, p2, Angelor Gargantini - Testing e

Example

Consider a system with the following parameters and values:
 parameter A has values WIN and LIN
 parameter B has values 1NT and AMD, and
 parameter C has values IPV4, IPV6

Pairwise testing t = 2

Step 1: the first t parameters

- if a test suite wants to cover all the t-combinations of t parameters, it must contain all the possible combinations
- ► t = 2
- parameter A has values WIN and LIN
- parameter B has values 1NT and AMD
- Initial test suite (CA):



Step 2: adding a new parameter

- Add the tests to cover the t+1 th parameter.
- Add a column to the CA for the new parameter
- For the values of the new

Horizontal Growth







Step 2 b

Check if all the tuples are covered, in case add new rows (vertical growth)

Vertical Growth





missing : AMD, IPV4 INT, IPV6 A B C WIN INTIPV4 WIN AMD IPV6 LIN INT IPV4 LIN AMD IPV6 LIN AMD IPV4 LIN INT IPV6

Exercise

- parameter A has values A1 and A2
- parameter B has values B1 and B2, and
- parameter C has values C1, C2, and C3

Example (2)



Horizontal Growth

Vertical Growth

Open problems

- When adding a new column, how to chose the values?
- When adding a new row, how to choose the new row?